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OPC Unified Architecture - Part 8: Data Access (IEC 62541-8:2015)

OPC Unified Architecture - Teil 8: Zugriff auf Automatisierungsdaten (IEC 62541-8:2015)

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Architecture unifiée OPC - Partie 8: Accès aux données (IEC 62541-8:2015) (standards.iteh.ai)

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EN 62541-8

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OPC unified architecture - Part 8: Data Access (IEC 62541-8:2015)

Architecture unifiée OPC - Partie 8: Accès aux données (IEC 62541-8:2015)

OPC Unified Architecture - Teil 8: Zugriff auf Automatisierungsdaten (IEC 62541-8:2015)

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European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

Foreword

The text of document 65E/381/CDV, future edition 2 of IEC 62541-8, prepared by SC 65E "Devices and integration in enterprise systems", of IEC/TC 65 "Industrial-process measurement, control and automation" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62541-8:2015.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with (dow) 2018-04-29 the document have to be withdrawn

This document supersedes EN 62541-8:2011.

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This document has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association, and supports essential requirements of EU Directive(s).

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Endorsement notice

The text of the International Standard IEC 62541-8:2015 was approved by CENELEC as a European Standard without any modification.

Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC/TR 62541-1	-	OPC unified architecture - Part 1: Overview and concepts	CLC/TR 62541-1	-
IEC 62541-3	· iT	OPC unified architecture - PREVIE Part 3: Address Space Model	EN 62541-3	-
IEC 62541-4	-	OPC Unified Architecture iteh.ai) Part 4: Services	EN 62541-4	-
IEC 62541-5	https://sta	OPC unified architecture 1-8:2015 an Part 5: Information Model (sist/735ab0ef-2f63-410 8661e475f291/sist-en-62541-8-2015	EN 62541-5 17-9269-	-
UNECE 20	-	Codes for Units of Measure Used in International Trade	-	-

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IEC 62541-8

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INTERNATIONAL STANDARD

NORME INTERNATIONALE



OPC Unified Architecture STANDARD PREVIEW Part 8: Data Access (standards.iteh.ai)

Architecture unifiée OPC - SIST EN 62541-82015

Partie 8: Accès aux/données ai/catalog/standards/sist/735ab0ef-2f63-41d7-9269-8661e475f291/sist-en-62541-8-2015

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

OPC UNIFIED ARCHITECTURE -

Part 8: Data Access

FOREWORD

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International Standard IEC 62541-8 has been prepared by subcommittee 65E: Devices and integration in enterprise systems, of IEC technical committee 65: Industrial-process measurement, control and automation.

This second edition cancels and replaces the first edition published in 2011. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) Clarified that deadband has to be between 0.0 and 100.0. Violations result in error Bad DeadbandFilterInvalid (6.2)
- b) Added VariableTypes handling Arrayltems and DataTypes supporting this, including complex number types. These data types are required for complex analyzer devices but seem useful for other domains as well.

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The text of this standard is based on the following documents:

CDV	Report on voting	
65E/381/CDV	65E/407/RVD	

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62541 series, published under the general title *OPC Unified Architecture*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed,
- withdrawn,
- · replaced by a revised edition, or
- amended.

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IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

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OPC UNIFIED ARCHITECTURE -

Part 8: Data Access

1 Scope

This part of IEC 62451 is part of the overall OPC Unified Architecture (OPC UA) standard series and defines the information model associated with Data Access (DA). It particularly includes additional *VariableTypes* and complementary descriptions of the *NodeClasses* and *Attributes* needed for Data Access, additional *Properties*, and other information and behaviour.

The complete address space model, including all *NodeClasses* and *Attributes* is specified in IEC 62541-3. The services to detect and access data are specified in IEC 62541-4.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

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IEC TR 62541-1, OPC Unified Architecture - Part 1: Overview and Concepts

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IEC 62541-3, OPC unified architecture a Part 3: Address Space Model 9269-

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IEC 62541-4, OPC unified architecture - Part 4: Services

IEC 62541-5, OPC unified architecture - Part 5: Information Model

UN/CEFACT: **UNECE Recommendation N° 20**, Codes for Units of Measure Used in International Trade, available at http://www.unece.org/cefact/recommendations/rec_index.htm

3 Terms, definitions and abbreviations

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC TR 62541-1, IEC 62541-3, and IEC 62541-4 as well as the following apply.

3.1.1

DataItem

link to arbitrary, live automation data, that is, data that represents currently valid information

Note 1 to entry: Examples of such data are

- · device data (such as temperature sensors),
- calculated data,
- · status information (open/closed, moving),
- dynamically-changing system data (such as stock quotes),
- diagnostic data.